## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LEE, JUNG SU Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,361,067 B1	03-2002	Varcus et al.	280/729
	В	US-5,913,535	06-1999	Taguchi et al.	280/729
	C	US-5,951,038	09-1999	Taguchi et al.	280/729
	D	US-6,382,662 B1	05-2002	Igawa, Tadahiro	280/729
	Е	US-5,246,250	09-1993	Wolanin et al.	280/739
	F	US-6,283,499 B1	09-2001	Nelsen et al.	280/729
	O	US-6,585,290 B2	07-2003	Pinsenschaum et al.	280/740
	Ι	US-			
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0			·· · · · · · · · · · · · · · · · · · ·		
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.